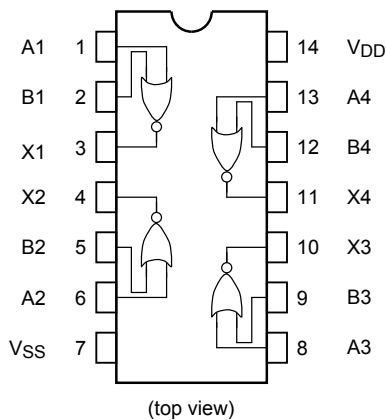


TC4001BP, TC4001BF, TC4001BFN, TC4001BFT

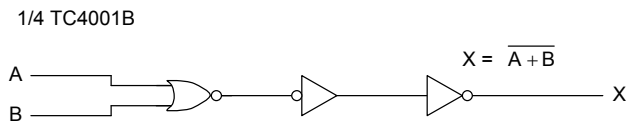
TC4001B Quad 2 Input NOR Gate

The TC4001B is 2-input positive NOR gate, respectively.
 Since the outputs of these gates are equipped with the buffers, the input/output transmission characteristics have been improved and the variation of transmission time due to an increase in the load capacity is kept minimum.

Pin Assignment

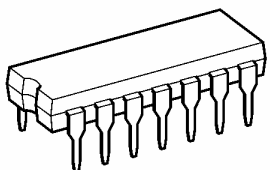


Logic Diagram



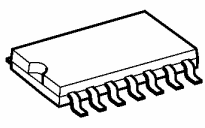
Note: xxxFN (JEDEC SOP) is not available in Japan.

TC4001BP



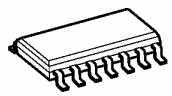
DIP14-P-300-2.54

TC4001BF



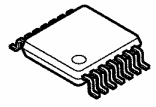
SOP14-P-300-1.27A

TC4001BFN



SOL14-P-150-1.27

TC4001BFT



TSSOP14-P-0044-0.65A

Weight	
DIP14-P-300-2.54	: 0.96 g (typ.)
SOP14-P-300-1.27A	: 0.18 g (typ.)
SOL14-P-150-1.27	: 0.12 g (typ.)
TSSOP14-P-0044-0.65A	: 0.06 g (typ.)

Absolute Maximum Ratings (Note)

Characteristics	Symbol	Rating	Unit
DC supply voltage	V_{DD}	$V_{SS} - 0.5$ to $V_{SS} + 20$	V
Input voltage	V_{IN}	$V_{SS} - 0.5$ to $V_{DD} + 0.5$	V
Output voltage	V_{OUT}	$V_{SS} - 0.5$ to $V_{DD} + 0.5$	V
DC input current	I_{IN}	± 10	mA
Power dissipation	P_D	300 (DIP)/180 (SOIC)	mW
Operating temperature range	T_{opr}	-40 to 85	°C
Storage temperature range	T_{stg}	-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Operating Ranges ($V_{SS} = 0$ V) (Note)

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
DC supply voltage	V_{DD}	—	3	—	18	V
Input voltage	V_{IN}	—	0	—	V_{DD}	V

Note: The operating ranges must be maintained to ensure the normal operation of the device.
Unused inputs must be tied to either V_{DD} or V_{SS} .

Static Electrical Characteristics (V_{SS} = 0 V)

Characteristics	Symbol	Test Condition	V _{DD} (V)	-40°C		25°C			85°C		Unit	
				Min	Max	Min	Typ.	Max	Min	Max		
High-level output voltage	V _{OH}	I _{OUT} < 1 μA V _{IN} = V _{SS} , V _{DD}	5	4.95	—	4.95	5.00	—	4.95	—	V	
			10	9.95	—	9.95	10.00	—	9.95	—		
			15	14.95	—	14.95	15.00	—	14.95	—		
Low-level output voltage	V _{OL}	I _{OUT} < 1 μA V _{IN} = V _{SS} , V _{DD}	5	—	0.05	—	0.00	0.05	—	0.05	V	
			10	—	0.05	—	0.00	0.05	—	0.05		
			15	—	0.05	—	0.00	0.05	—	0.05		
Output high current	I _{OH}	V _{OH} = 4.6 V	5	-0.61	—	-0.51	-1.0	—	-0.42	—	mA	
		V _{OH} = 2.5 V	5	-2.50	—	-2.10	-4.0	—	-1.70	—		
		V _{OH} = 9.5 V	10	-1.50	—	-1.30	-2.2	—	-1.10	—		
		V _{OH} = 13.5 V	15	-4.00	—	-3.40	-9.0	—	-2.80	—		
		V _{IN} = V _{SS}										
Output low current	I _{OL}	V _{OL} = 0.4 V	5	0.61	—	0.51	1.2	—	0.42	—	mA	
		V _{OL} = 0.5 V	10	1.50	—	1.30	3.2	—	1.10	—		
		V _{OL} = 1.5 V	15	4.00	—	3.40	12.0	—	2.80	—		
		V _{IN} = V _{SS} , V _{DD}										
Input high voltage	V _{IH}	V _{OUT} = 0.5 V	5	3.5	—	3.5	2.75	—	3.5	—	V	
		V _{OUT} = 1.0 V	10	7.0	—	7.0	5.50	—	7.0	—		
		V _{OUT} = 1.5 V	15	11.0	—	11.0	8.25	—	11.0	—		
		I _{OUT} < 1 μA										
Input low voltage	V _{IL}	V _{OUT} = 4.5 V	5	—	1.5	—	2.25	1.5	—	1.5	V	
		V _{OUT} = 9.0 V	10	—	3.0	—	4.50	3.0	—	3.0		
		V _{OUT} = 13.5 V	15	—	4.0	—	6.75	4.0	—	4.0		
		I _{OUT} < 1 μA										
Input current	"H" level	I _{IH}	V _{IH} = 18 V	18	—	0.1	—	10 ⁻⁵	0.1	—	1.0	μA
	"L" level	I _{IL}	V _{IL} = 0 V	18	—	-0.1	—	-10 ⁻⁵	-0.1	—	-1.0	
Quiescent supply current	I _{DD}	V _{IN} = V _{SS} , V _{DD} (Note)	5	—	0.25	—	0.001	0.25	—	7.5	μA	
			10	—	0.50	—	0.001	0.50	—	15.0		
			15	—	1.00	—	0.002	1.00	—	30.0		

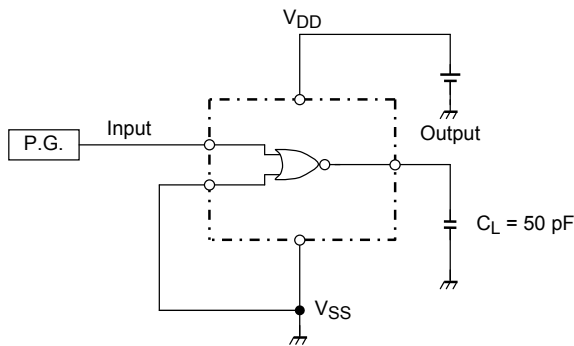
Note: All valid input combinations.

Dynamic Electrical Characteristics (Ta = 25°C, VSS = 0 V, CL = 50 pF)

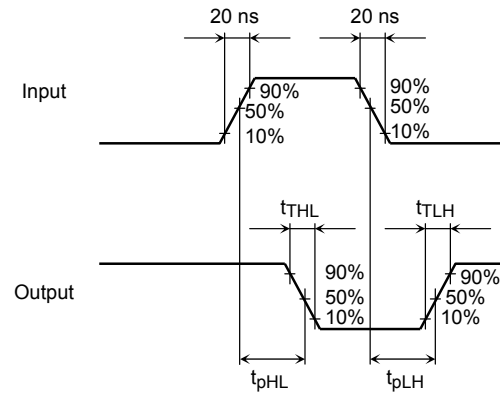
Characteristics	Symbol	Test Condition	VDD (V)	Min	Typ.	Max	Unit
Output transition time	t _{TLH}	—	5	—	70	200	ns
			10	—	35	100	
			15	—	30	80	
Output transition time	t _{THL}	—	5	—	70	200	ns
			10	—	35	100	
			15	—	30	80	
Propagation delay time	t _{pLH}	—	5	—	65	200	ns
			10	—	30	100	
			15	—	25	80	
Propagation delay time	t _{pHL}	—	5	—	65	200	ns
			10	—	30	100	
			15	—	25	80	
Input capacitance	C _{IN}	—	—	5	7.5	pF	

Circuit and Waveform for Measurement of Dynamic Characteristics

Circuit



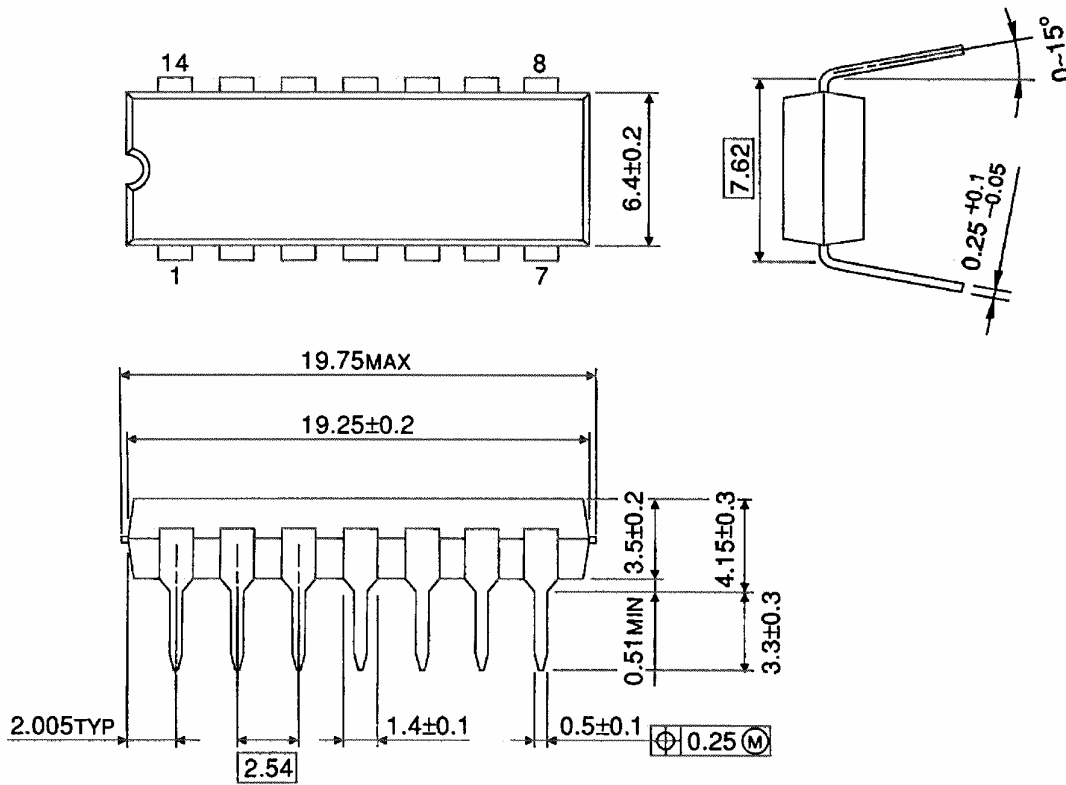
Waveform



Package Dimensions

DIP14-P-300-2.54

Unit : mm

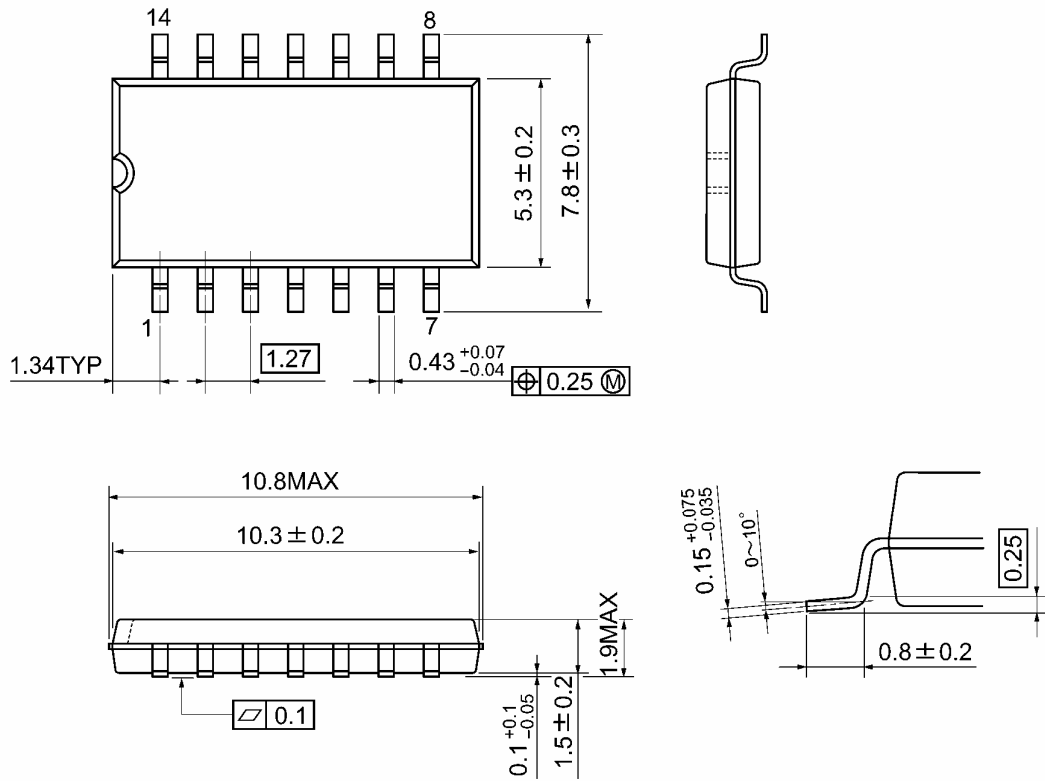


Weight: 0.96 g (typ.)

Package Dimensions

SOP14-P-300-1.27A

Unit: mm

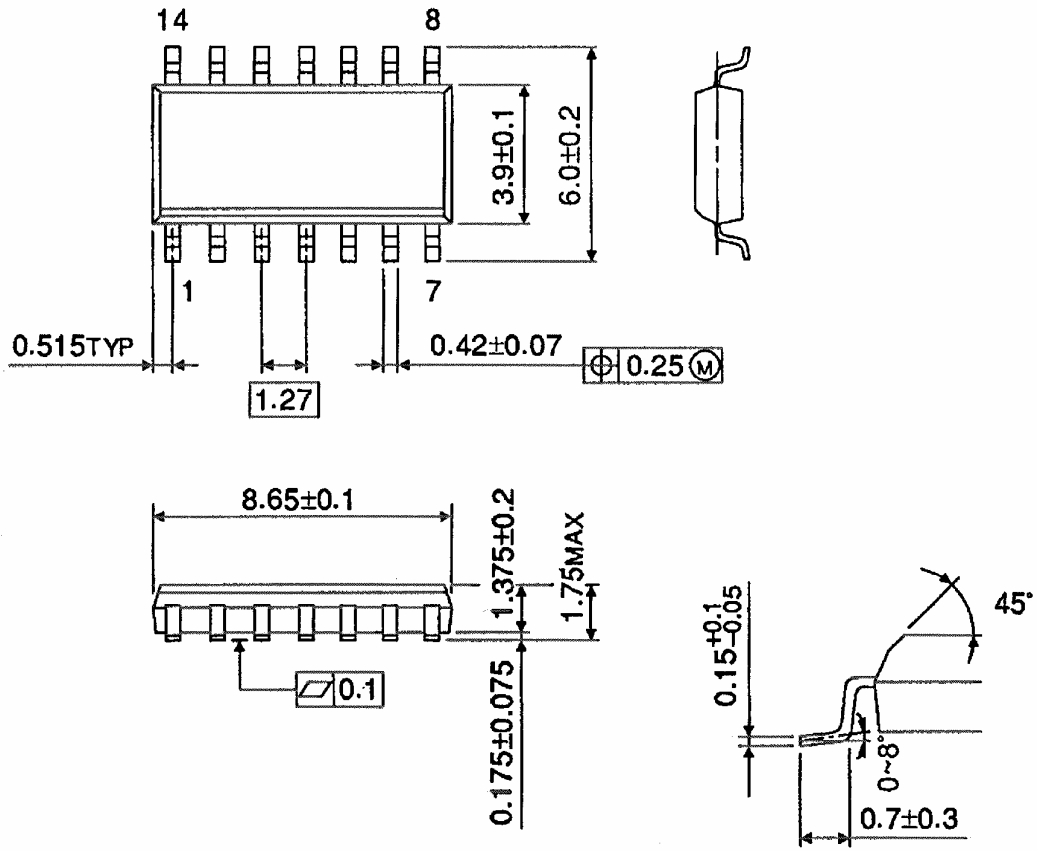


Weight: 0.18 g (typ.)

Package Dimensions (Note)

SOL14-P-150-1.27

Unit : mm



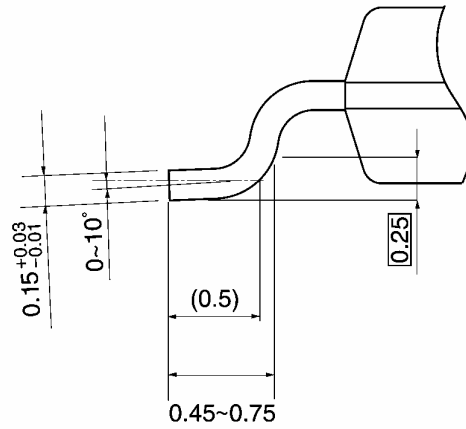
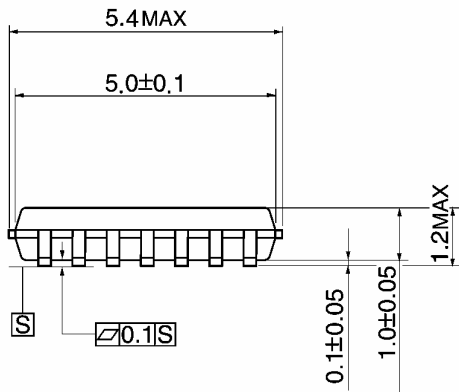
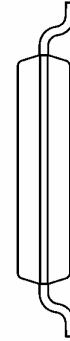
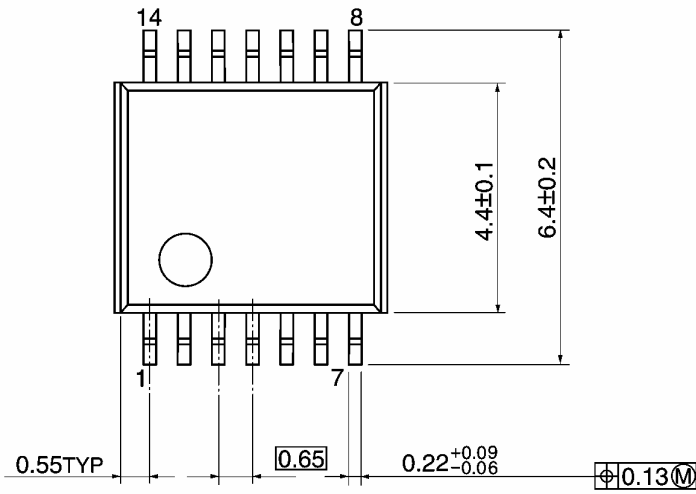
Note: This package is not available in Japan.

Weight: 0.12 g (typ.)

Package Dimensions

TSSOP14-P-0044-0.65A

Unit: mm



Weight: 0.06 g (typ.)

RESTRICTIONS ON PRODUCT USE

20070701-EN GENERAL

- The information contained herein is subject to change without notice.
- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc.
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk.
- The products described in this document shall not be used or embedded to any downstream products of which manufacture, use and/or sale are prohibited under any applicable laws and regulations.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA for any infringements of patents or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any patents or other rights of TOSHIBA or the third parties.
- Please contact your sales representative for product-by-product details in this document regarding RoHS compatibility. Please use these products in this document in compliance with all applicable laws and regulations that regulate the inclusion or use of controlled substances. Toshiba assumes no liability for damage or losses occurring as a result of noncompliance with applicable laws and regulations.